

<b>Notice of References Cited</b>	Application/Control No. 10/614,828		Applicant(s)/Patent Under Reexamination TAMIYA ET AL.	
	Examiner Susan S. Lee		Art Unit 2852	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,618,565 B2	09-2003	Tamiya et al.	399/66
	B	US-6,421,521 B2	07-2002	Tanaka, Yasuo	399/299
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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